

MOTOROLA SEMICONDUCTOR TECHNICAL DATA

2N4427

The RF Line

NPN SILICON HIGH FREQUENCY TRANSISTOR

... designed for amplifier, frequency multiplier, or oscillator applications in military and industrial equipment. Suitable for use as output driver or pre-driver stages in VHF and UHF equipment.

- Specified 175 MHz, 12 Vdc Characteristics –
 Output Power = 1.0 Watt
 Minimum Gain = 10 dB
 Efficiency = 50%

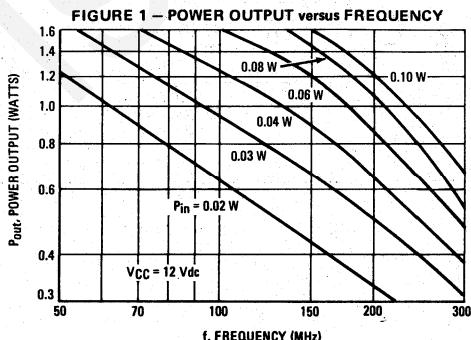


Island Labs

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
*Collector-Emitter Voltage	V _{CEO}	20	Vdc
*Collector-Base Voltage	V _{CB}	40	Vdc
*Emitter-Base Voltage	V _{EB}	2.0	Vdc
*Collector Current – Continuous	I _C	400	mAdc
*Base Current – Continuous	I _B	400	mAdc
Total Device Dissipation @ T _A = 25°C Derate above 25°C	P _D	1.0 5.71	Watt mW/°C
*Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	3.5 20	Watts mW/°C
*Storage Temperature Range	T _{stg}	-65 to +200	°C

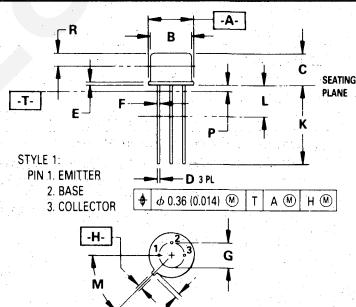
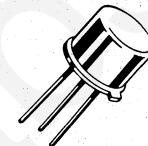
*Indicates JEDEC Registered Data



1 W – 175 MHz

HIGH FREQUENCY TRANSISTOR

NPN SILICON



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION J MEASURED FROM DIMENSION A MAXIMUM.
 4. DIMENSION B SHALL NOT VARY MORE THAN 0.25 (0.010) IN ZONE R. THIS ZONE CONTROLLED FOR AUTOMATIC HANDLING.
 5. DIMENSION F APPLIES BETWEEN DIMENSION P AND L. DIMENSION D APPLIES BETWEEN DIMENSION L AND K MINIMUM. LEAD DIAMETER IS UNCONTROLLED IN DIMENSION P AND BEYOND DIMENSION K MINIMUM.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	8.51	9.39	0.335	0.370
B	7.75	8.50	0.305	0.335
C	6.10	6.60	0.240	0.260
D	0.41	0.53	0.016	0.021
E	0.23	1.04	0.009	0.041
F	0.41	0.48	0.016	0.019
G	5.08 BSC		0.200 BSC	
H	0.72	0.86	0.028	0.034
J	0.74	1.14	0.029	0.045
K	12.70	19.05	0.500	0.750
L	6.35	—	0.250	—
M	45° BSC		45° BSC	
P	—	1.27	—	0.050
R	2.54	—	0.100	—

CASE 79-04

TO-205AD

(TO-39)

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
*Collector-Emitter Sustaining Voltage ($I_C = 5.0 \text{ mA DC}, I_B = 0$)	$V_{CEO(\text{sus})}$	20	—	Vdc
*Collector-Emitter Sustaining Voltage ($I_C = 5.0 \text{ mA DC}, R_{BE} = 10 \text{ ohms}$)	$V_{CE(\text{sus})}$	40	—	Vdc
*Collector Cutoff Current ($V_{CE} = 12 \text{ Vdc}, I_B = 0$)	I_{CEO}	—	0.02	mA DC
*Collector Cutoff Current ($V_{CE} = 40 \text{ Vdc}, V_{BE} = -1.5 \text{ Vdc}$) ($V_{CE} = 12 \text{ Vdc}, V_{BE} = -1.5 \text{ Vdc}, T_C = +150^\circ\text{C}$)	I_{CEV}	—	0.1 5.0	mA DC
*Emitter Cutoff Current ($V_{EB} = 2.0 \text{ Vdc}, I_C = 0$)	I_{EBO}	—	0.1	mA DC
ON CHARACTERISTICS				
*DC Current Gain ($I_C = 100 \text{ mA DC}, V_{CE} = 5.0 \text{ Vdc}$) ($I_C = 360 \text{ mA DC}, V_{CE} = 5.0 \text{ Vdc}$)	h_{FE}	10 5.0	200	—
*Collector-Emitter Saturation Voltage ($I_C = 100 \text{ mA DC}, I_B = 20 \text{ mA DC}$)	$V_{CE(\text{sat})}$	—	0.5	Vdc
DYNAMIC CHARACTERISTICS				
*Current-Gain – Bandwidth Product ($I_C = 50 \text{ mA DC}, V_{CE} = 15 \text{ Vdc}, f = 200 \text{ MHz}$)	f_T	500	—	MHz
*Output Capacitance ($V_{CB} = 12 \text{ Vdc}, I_E = 0, f = 1.0 \text{ MHz}$)	C_{ob}	—	4.0	pF
FUNCTIONAL TEST				
*Power Input (Figure 2) ($P_{out} = 1.0 \text{ W}, V_{CC} = 12 \text{ Vdc}, f = 175 \text{ MHz}$)	P_{in}	—	100	mW
Common-Emitter Amplifier Power Gain ($P_{in} = 100 \text{ mW}, V_{CC} = 12 \text{ Vdc}, f = 175 \text{ MHz}$)	G_{pe}	10	—	dB
*Collector Efficiency (Figure 2) ($P_{out} = 1.0 \text{ W}, V_{CC} = 12 \text{ Vdc}, f = 175 \text{ MHz}$)	η	50	—	%

*Indicates JEDEC Registered Data

FIGURE 2 – 175 MHZ RF AMPLIFIER CIRCUIT FOR POWER-OUTPUT TEST

